

## DIGITAL AMPLIFIER POWER STAGE



### FEATURES

- 100-W RMS Power (BTL) Into 4  $\Omega$  With Less Than 10% THD+N
- 80-W RMS Power (BTL) Into 4  $\Omega$  With Less Than 0.2% THD+N
- 0.05% THD+N at 1 W Into 4  $\Omega$
- Power Stage Efficiency Greater Than 90% Into 4  $\Omega$  Load
- Self-Protecting Design
- 36-Pin PSOP3 Package
- 3.3-V Digital Interface
- EMI Compliant When Used With Recommended System Design

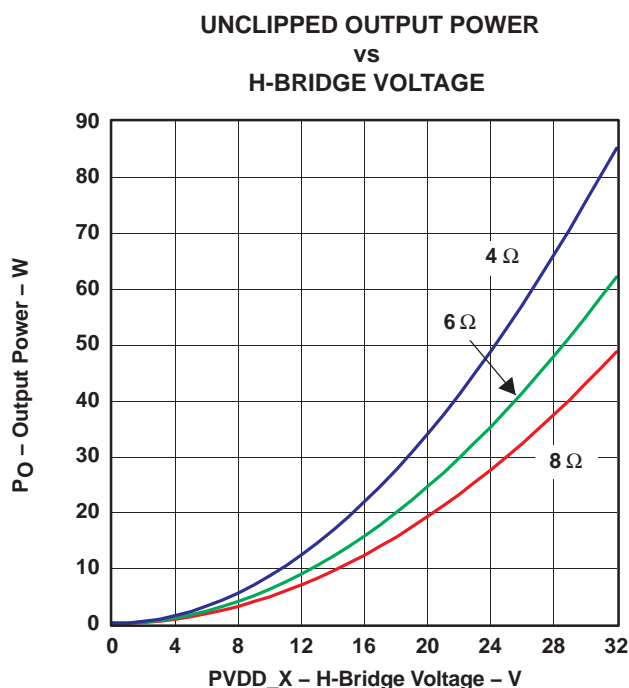
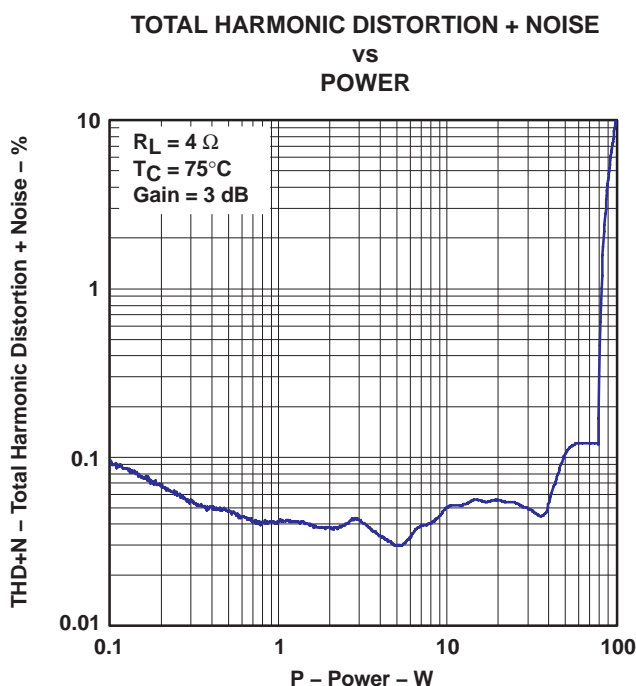
### APPLICATIONS

- DVD Receiver
- Home Theatre
- Mini/Micro Component Systems
- Internet Music Appliance

### DESCRIPTION

The TAS5121 is a high-performance digital amplifier power stage designed to drive a 4- $\Omega$  speaker up to 100 W. The device incorporates PurePath Digital™ technology and can be used with a TI audio PWM processor and a simple passive demodulation filter to deliver high-quality, high-efficiency digital audio amplification.

The efficiency of this digital amplifier can be greater than 90%, depending on the system design. Overcurrent protection, overtemperature protection, and undervoltage protection are built into the TAS5121, safeguarding the device and speakers against fault conditions that could damage the system.



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# TAS5121

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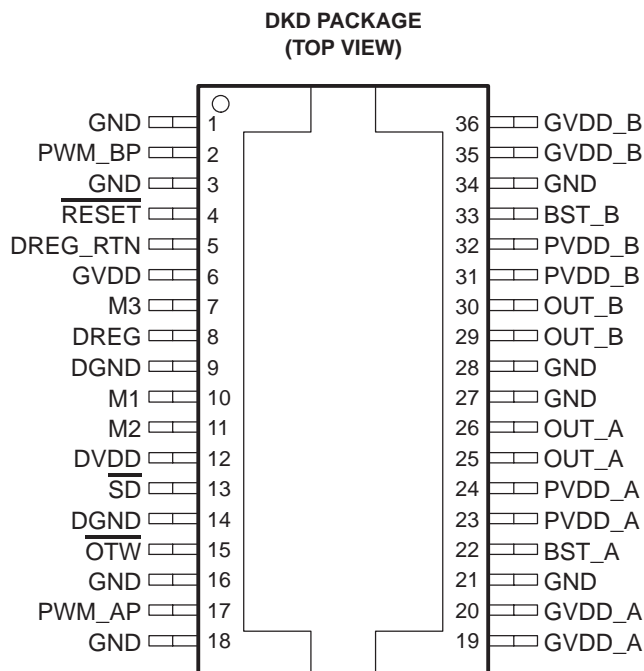


These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## GENERAL INFORMATION

### Terminal Assignment

The TAS5121 is offered in a thermally enhanced 36-pin PSOP3 (DKD) package. The DKD package has the thermal pad on top.



## ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range unless otherwise noted<sup>(1)</sup>

TAS5121	UNITS
DVDD TO DGND	–0.3 V to 4.2 V
GVDD_X TO GND	14.2 V
PVDD_X TO GND (dc voltage)	33.5 V
PVDD_X TO GND <sup>(2)</sup>	48 V
OUT_X TO GND (dc voltage)	33.5 V
OUT_X TO GND <sup>(2)</sup>	48 V
BST_X TO GND (DC voltage)	46 V
BST_X TO GND <sup>(2)</sup>	53 V
PWM_XP, RESET, M1, M2, M3, SD, OTW	–0.3 V to DVDD + 0.3 V
Maximum junction temperature range, T <sub>J</sub>	–40°C to 150°C
Storage temperature	–40°C to 125°C

(1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The duration should be less than 100 ns (see application note SLEA025).

## ORDERING INFORMATION

T <sub>A</sub>	PACKAGE	TRANSPORT MEDIA	DESCRIPTION
0°C to 70°C	TAS5121DKD	Tube	36-pin PSOP3
0°C to 70°C	TAS5121DKDR	Tape and reel	36-pin PSOP3

## PACKAGE DISSIPATION RATINGS

PACKAGE	R <sub>θJC</sub> (°C/W)	R <sub>θJA</sub> (°C/W)
36-Pin DKD PSOP3	0.85	See Note 1

(1) The TAS5121 package is thermally enhanced for conductive cooling using an exposed metal pad area. It is impractical to use the devices with the pad exposed to ambient air as the only heat sinking of the device.

For this reason, R<sub>θJA</sub>, a system parameter that characterizes the thermal treatment, is provided in the *Application Information* section of the data sheet. An example and discussion of typical system R<sub>θJA</sub> values are provided in the *Thermal Information* section. This example provides additional information regarding the power dissipation ratings. This example should be used as a reference to calculate the heat dissipation ratings for a specific application.

## Terminal Functions

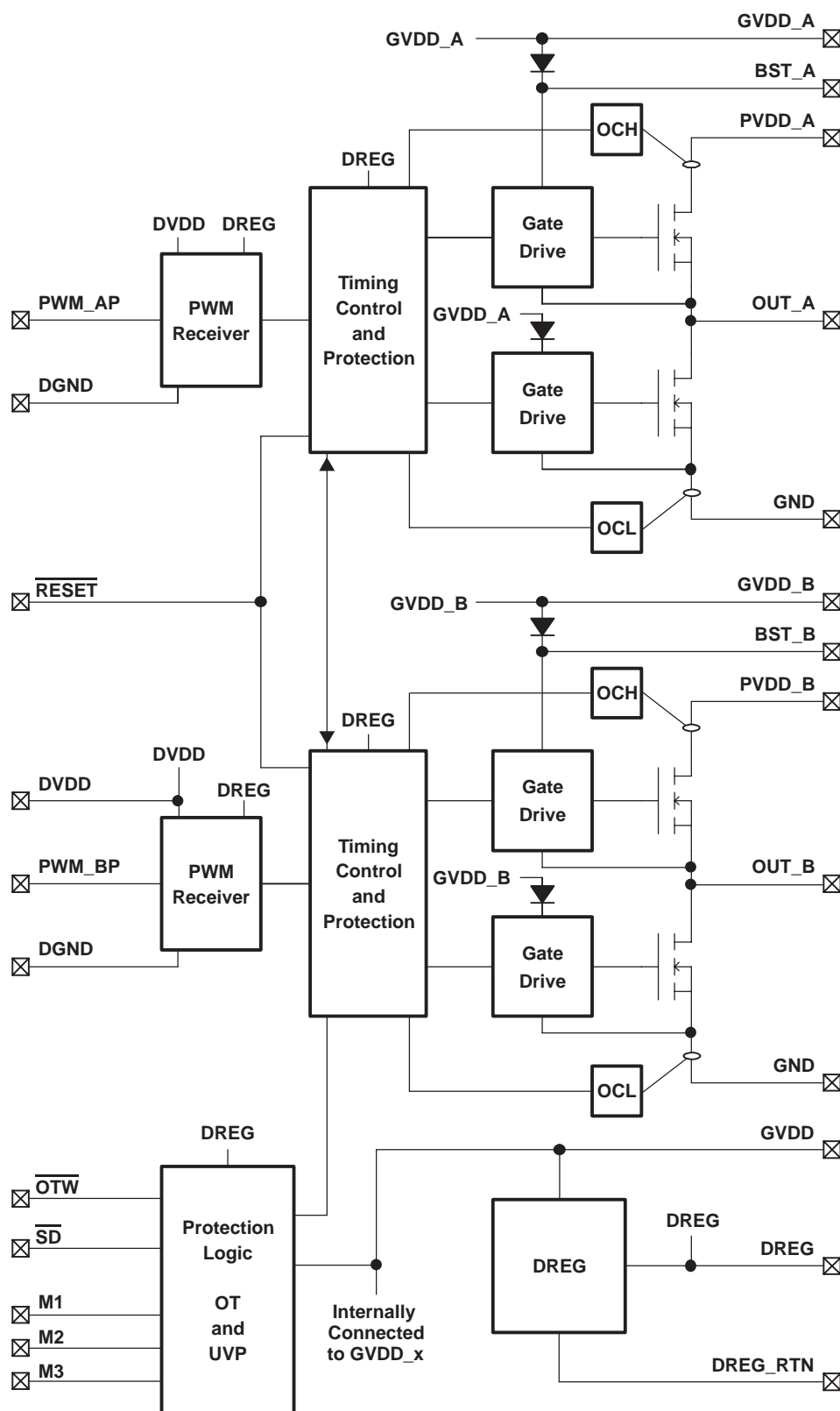
TERMINAL		FUNCTION(1)	DESCRIPTION
NAME	DKD		
BST_A	22	P	High-side bootstrap supply (BST), external resistor and capacitor to OUT_A required
BST_B	33	P	High-side bootstrap supply (BST), external resistor and capacitor to OUT_B required
DGND	9, 14	P	I/O reference ground
DREG	8	P	Digital supply voltage regulator decoupling pin, 1- $\mu$ F capacitor connected to DREG_RTN
DREG_RTN	5	P	Decoupling return pin
DVDD	12	P	I/O reference supply input: 100 $\Omega$ to DREG, decoupled to GND, 0.1- $\mu$ F capacitor connected to GND
GND	1, 3, 16, 18, 21, 27, 28, 34	P	Power ground, connected to system GND
GVDD	6	P	Local GVDD decoupling \pin
GVDD_A	19, 20	P	Gate drive input voltage
GVDD_B	35, 36	P	Gate drive input voltage
M1	10	I	Protection mode selection pin, connect to GND
M2	11	I	Protection mode selection pin, connect to DREG
M3	7	I	Output mode selection pin; connect to GND
OTW	15	O	Overtemperature warning output, open drain with internal pullup resistor, active-low when temperature exceeds 115°C
OUT_A	25, 26	O	Output, half-bridge A
OUT_B	29, 30	O	Output, half-bridge B
PVDD_A	23, 24	P	Power supply input for half-bridge A
PVDD_B	31, 32	P	Power supply input for half-bridge B
PWM_AP	17	I	PWM input signal, half-bridge A
PWM_BP	2	I	PWM input signal, half-bridge B
RESET	4	I	Reset signal, active-low
SD	13	O	Shutdown signal for half-bridges A and B (open drain with internal pullup resistor), active-low

(1) I = input, O = Output, P = Power

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## FUNCTIONAL BLOCK DIAGRAM



## RECOMMENDED OPERATING CONDITIONS

			MIN	TYP	MAX	UNIT
DVDD	Digital supply <sup>(1)</sup>	Relative to DGND	3	3.3	3.6	V
GVDD_x	Supply for internal gate drive and logic regulators	Relative to GND	10.8	12	13.2	V
PVDD_x	Half-bridge supply	Relative to GND, $R_L = 4\ \Omega$	0	30.5	32	V
T <sub>J</sub>	Junction temperature		0		125	°C

(1) It is recommended for DVDD to be connected to DREG via a 100- $\Omega$  resistor.

## ELECTRICAL CHARACTERISTICS

PVDD\_X = 30.5 V, GVDD\_x = 12 V, DVDD connected to DREG via a 100- $\Omega$  resistor,  $R_L = 4\ \Omega$ ,  $8X\ f_s = 384\ \text{kHz}$ , TAS5026 PWM processor, unless otherwise noted

SYMBOL	PARAMETER	TEST CONDITIONS	TYPICAL	OVER TEMPERATURE			
			T <sub>A</sub> =25°C	T <sub>A</sub> =25°C	T <sub>C</sub> =75°C	UNITS	MIN/TYP/ MAX
AC PERFORMANCE, BTL Mode, 1 kHz							
Po	Output power	R <sub>L</sub> = 4 Ω, THD = 10%, AES17 filter			100	W	Typ
		R <sub>L</sub> = 4 Ω, THD = unclipped, AES17 filter			80	W	Typ
		R <sub>L</sub> = 8 Ω, THD =unclipped, AD mode			44	W	Typ
THD+N	Total harmonic distortion + noise	Po = 1 W/ channel, R <sub>L</sub> = 4 Ω, AES17 filter			0.05	%	Typ
		Po = 10 W/channel, R <sub>L</sub> = 4 Ω, AES17 filter			0.1	%	Typ
		Po = 80 W/channel, R <sub>L</sub> = 4 Ω, AES17 filter			0.2	%	Typ
V <sub>n</sub>	Output integrated noise voltage	A-weighted, R <sub>L</sub> = 4 Ω, 20 Hz to 20 kHz, AES17 filter			300	μV	Max
SNR	Signal-to-noise ratio	A-weighted, AES17 filter			95	dB	Typ
DR	Dynamic range	f = 1 kHz, –60 dB, A-weighted, AES17 filter			95	dB	Typ

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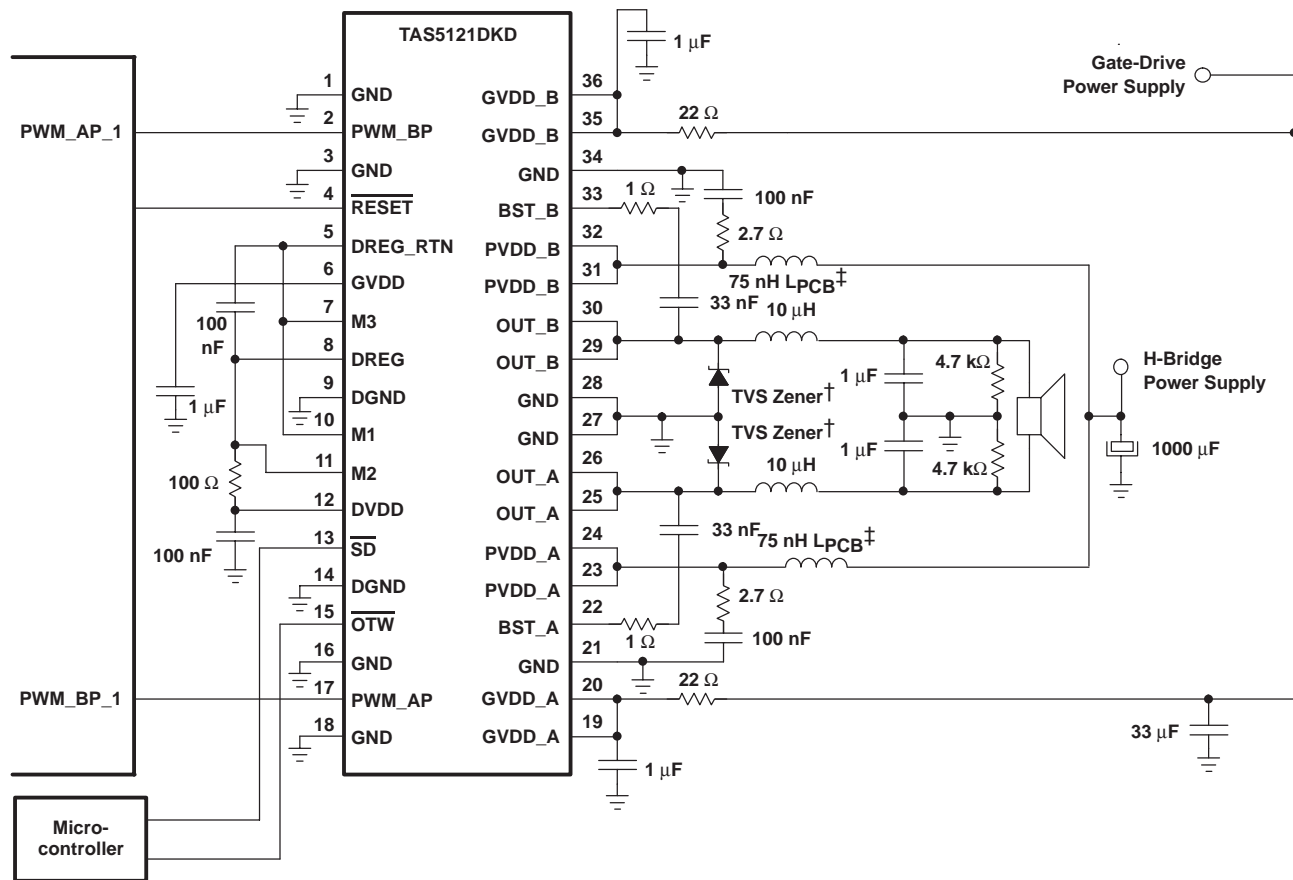
## ELECTRICAL CHARACTERISTICS

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SYMBOL	PARAMETER	TEST CONDITIONS	TYPICAL	OVER TEMPERATURE			
			T <sub>A</sub> =25°C	T <sub>A</sub> =25°C	T <sub>C</sub> =75°C	UNITS	MIN/TYP/ MAX
INTERNAL VOLTAGE REGULATOR AND CURRENT CONSUMPTION							
DREG	Voltage regulator	I <sub>O</sub> = 1 mA	3.3			V	Min
						V	Max
IGVDD_x	Total GVDD supply current, operating	f <sub>S</sub> = 384 kHz, no load, 50% duty cycle	24	30		mA	Max
IDVDD	DVDD supply current, operating	f <sub>S</sub> = 384 kHz, no load	1	5		mA	Max
OUTPUT STAGE MOSFETs							
R <sub>DSon,LS</sub>	Forward on-resistance, low side	T <sub>J</sub> = 25°C	120	132		mΩ	Max
R <sub>DSon,HS</sub>	Forward on-resistance, high side	T <sub>J</sub> = 25°C	120	132		mΩ	Max
INPUT/OUTPUT PROTECTION							
V <sub>uvp,G</sub>	Undervoltage protection limit, GVDD		7.6	7		V	Min
				8.2		V	Max
OTW	Overtemperature warning	Static	115			°C	Typ
OTE	Overtemperature error	Static	150			°C	Typ
OC	Overcurrent protection	See Note 1.	9.5			A	Min
STATIC DIGITAL INPUT SPECIFICATION, PWM, PROTECTION MODE SELECTION PINS AND OUTPUT MODE SELECTION PINS							
V <sub>IH</sub>	High-level input voltage			2		V	Min
				DVDD		V	Max
V <sub>IL</sub>	Low-level input voltage			0.8		V	Max
Leakage	Input leakage current			–10		μA	Min
				10		μA	Max
OTW/SHUTDOWN (SD)							
	Internal pullup resistor from <u>OTW</u> and <u>SD</u> to DVDD		32	22		kΩ	Min
V <sub>OL</sub>	Low-level output voltage	I <sub>O</sub> = 1 mA		0.4		V	Max

(1) To optimize device performance and prevent overcurrent (OC) protection activation, the demodulation filter must be designed with special care. See *Demodulation Filter Design* in the *Application Information* section of the data sheet and consider the recommended inductors and capacitors for optimal performance. It is also important to consider PCB design and layout for optimum performance of the TAS5121.

# TYPICAL APPLICATION AND CHARACTERIZATION CONFIGURATION USED WITH TAS5026 PWM PROCESSOR



† Voltage suppressor diodes: 1SMA33CAT3

‡ L<sub>PCB</sub> : Track in the PCB 1,0 mm wide and 50 mm long)

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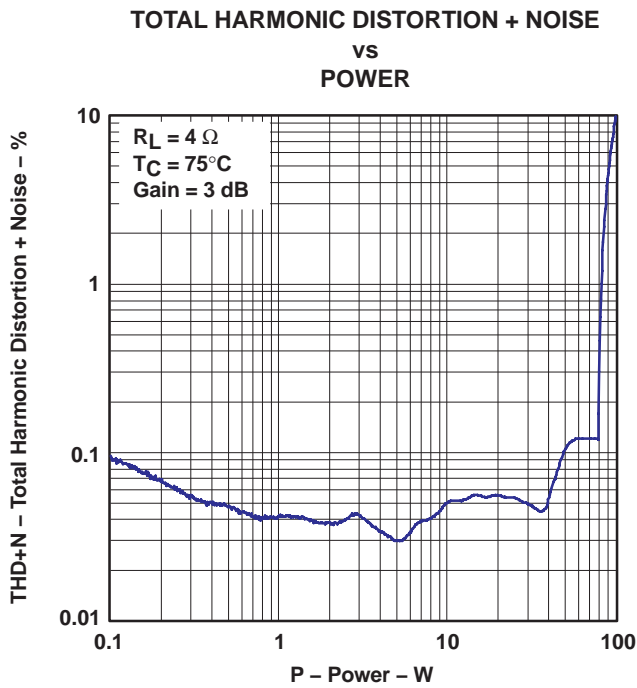


Figure 1

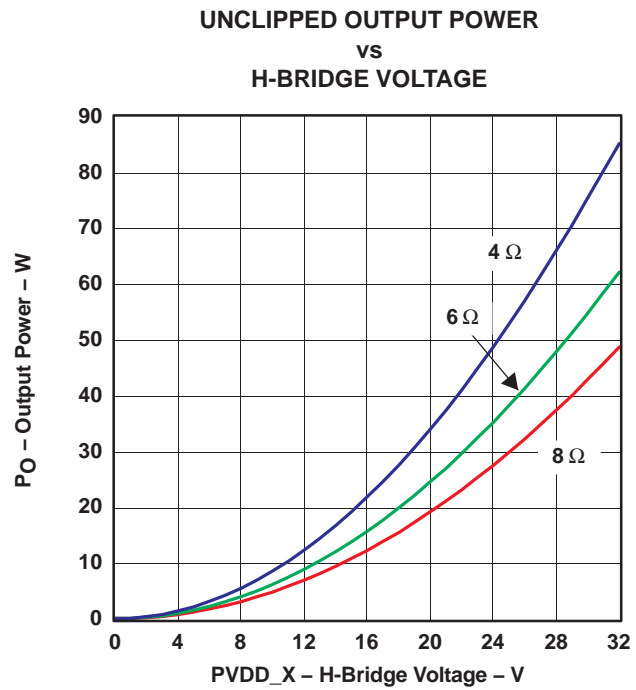


Figure 2

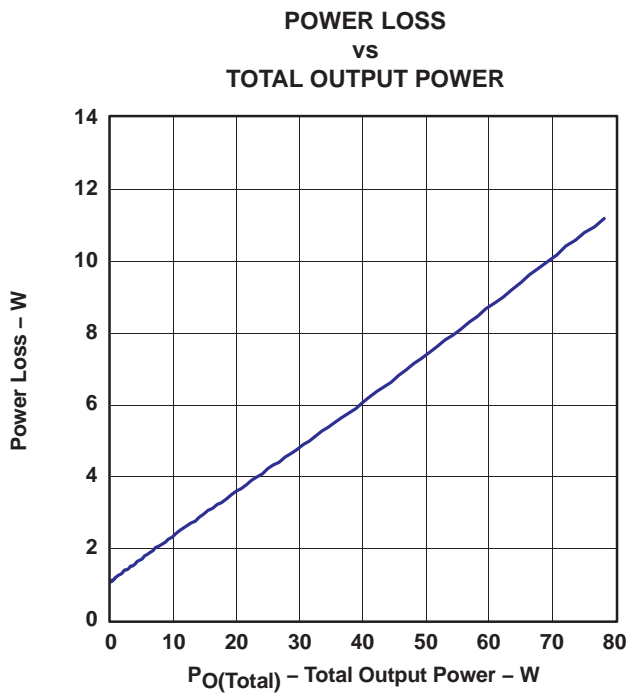


Figure 3

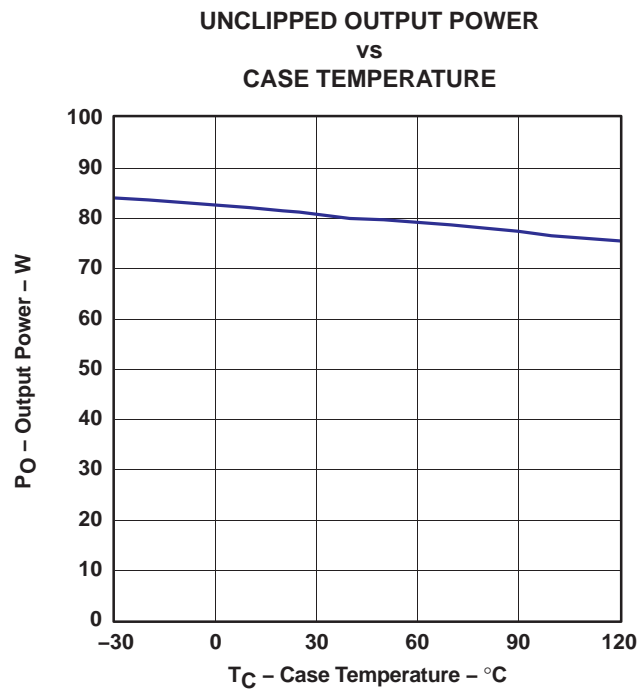
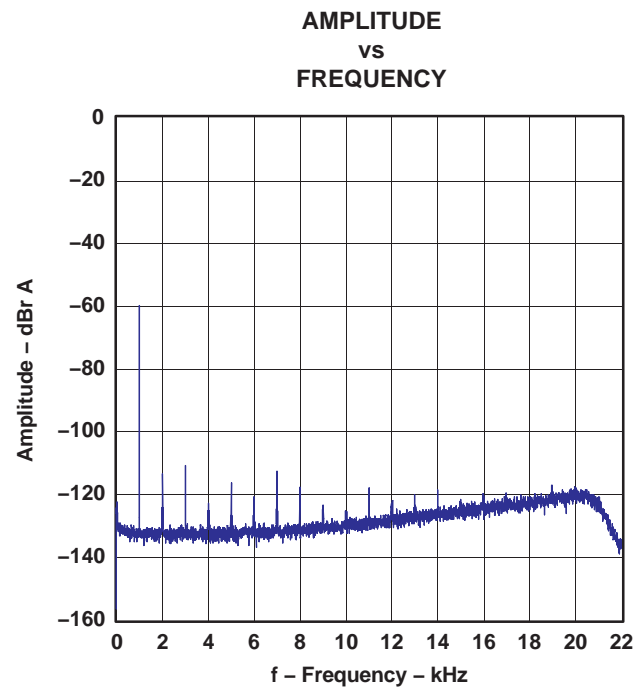
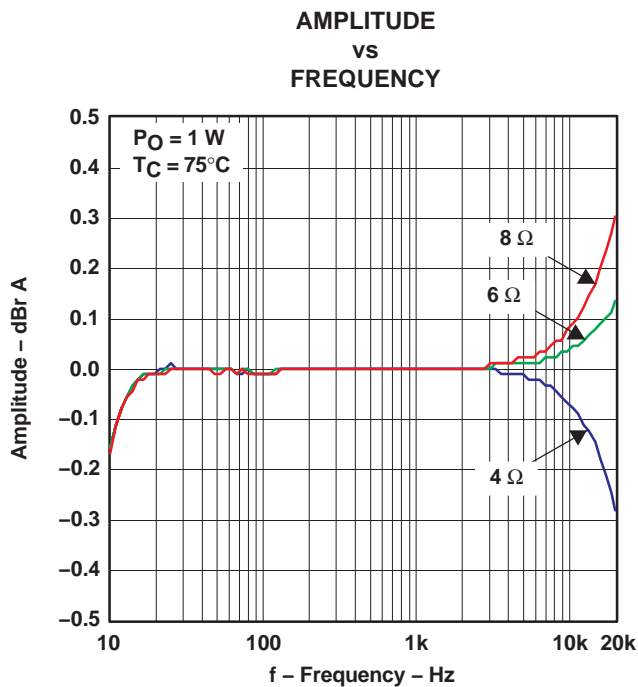
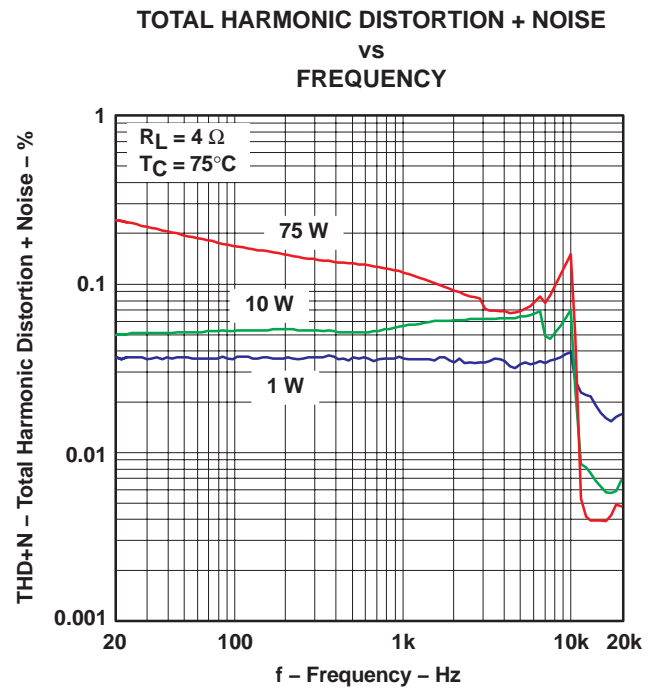
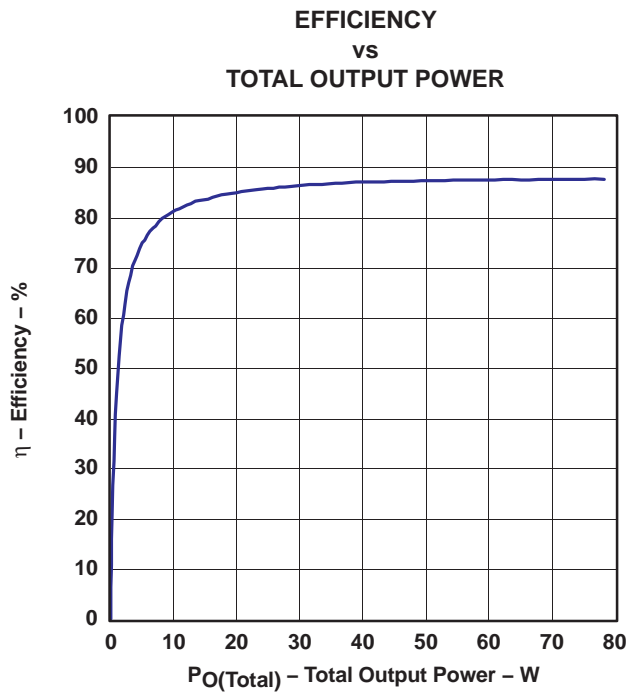


Figure 4





## THEORY OF OPERATION

### POWER SUPPLIES

This power device requires only two power supply voltages, GVDD\_x and PVDD\_x.

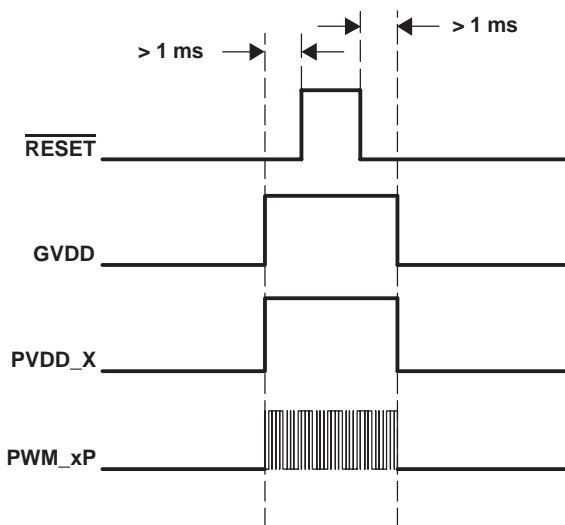
GVDD\_x is the gate drive supply for the device, which is usually supplied from an external 12-V power supply. GVDD\_x is also connected to an internal LDR that regulates the GVDD\_x voltage down to the logic power supply, 3.3 V, for the TAS5121 internal logic blocks. Each GVDD\_x pin is decoupled to system ground by a 1-μF capacitor.

PVDD\_x is the H-bridge power supply. Two power pins are provided for each half-bridge due to the high current density. It is important to follow the circuit and PCB layout recommendations for the design of the PVDD\_x connection. For component suggestions, see the *Typical System Configuration* section in this document. For layout guidelines, see the reference design layout for the TAS5121. Following these recommendations is important because they influence key system parameters such as EMI, idle current, and audio performance.

When GVDD\_x is applied, while **RESET** is held low, the error latches are cleared, **SHUTDOWN** is set high, and the outputs are held in a high-impedance state. The bootstrap capacitor is charged by the current path through the internal bootstrap diode and external resistors placed on the PCB from each OUT\_x pin to ground. A subsequent section describes the charging of the bootstrap capacitor.

Ideally, PVDD\_x is applied after GVDD\_x. When GVDD\_x and PVDD\_x are applied, the TAS5121 is ready for operation. PWM input signals can then be applied any time during the power-on sequence, but they must be active and stable before **RESET** is set high.

## RECOMMENDATIONS FOR POWERING UP



The following table describes the input conditions and the output states of the device:

INPUTS				OUTPUTS		Condition Description
<b>RESET</b>	<b>PWM_AP</b>	<b>PWM_BP</b>	<b>SHUT-DOWN</b>	<b>OUT_A</b>	<b>OUT_B</b>	
X	X	X	0	Hi-Z	Hi-Z	Shutdown
0	X	X	1	Hi-Z	Hi-Z	Reset
1	0	0	1	GND	GND	
1	0	0	1	PVDD	PVDD	Normal
1	0	1	1	GND	PVDD	Normal
1	1	1	1	PVDD	PVDD	Reserved

After the previously mentioned conditions are met, the device output begins. If PWM\_AP is equal to a high and PWM\_BP is equal to a low, the high-side MOSFET in the A half-bridge of the output H-bridge conducts while the low-side MOSFET in the A half-bridge is not conducting. Because the source of the high-side MOSFET is referenced to the drain of the low-side MOSFET, a bootstrapped gate drive is used to eliminate the need for additional high-voltage power supplies. Under the above condition, the opposite is true for the B half-bridge of the output H-bridge. The low-side MOSFET in B half-bridge conducts while the high-side MOSFET is not conducting; therefore, the load connected between the OUT\_A and OUT\_B pins has PVDD applied to it from the A side while ground is applied from the B side for the period of time PWM\_AP is high and PWM\_BP is low. Furthermore, when the PWM signals change to the condition where PWM\_AP is low and PWM\_BP is high, the opposite condition exists.

A constant high level is not permitted on the PWM inputs. This condition causes the bootstrap capacitors to discharge and can cause device damage.

A digitally controlled dead-time circuit controls the transitions between the high-side and low-side MOSFETs to ensure that both devices in each half-bridge are not conducting simultaneously.

## POWERING DOWN

For power down of the TAS5121, an opposite approach is necessary. The  $\overline{\text{RESET}}$  must be asserted LOW before the valid PWM signal is removed.

## PRECAUTION

The TAS5121 must always start up in the high-impedance (Hi-Z) state. In this state, the bootstrap (BST) capacitor is precharged by a resistor on each PWM output node to ground. See the system configuration. This ensures that the TAS5121 is ready for receiving PWM pulses, indicating either HIGH- or LOW-side turnon after  $\overline{\text{RESET}}$  is de-asserted to the back end.

With the following pulldown resistor and BST capacitor size, the BST charge time is:

$$C = 33 \text{ nF}, R = 4.7 \text{ k}\Omega$$

$$R \times C \times 5 = 775.5 \mu\text{s}$$

After GVDD has been applied, it takes approximately 800  $\mu\text{s}$  to fully charge the BST capacitor. During this time,  $\overline{\text{RESET}}$  must be kept low. After approximately 1 ms the back end BST is charged and ready.  $\overline{\text{RESET}}$  can now be released if the PWM modulator is ready and is streaming valid PWM signals to the device. Valid PWM signals are switching PWM signals with a frequency between 350–400 kHz. A constant HIGH level on the PWM+ forces the high-side MOSFET ON until it eventually runs out of BST capacitor energy. Putting the device in this condition should be avoided.

In practice this means that the DVDD-to-PWM processor (front-end) should be stable and initialization should be completed before  $\overline{\text{RESET}}$  is de-asserted to the TAS5121.

## CONTROL I/O

### Shutdown Pin: $\overline{\text{SD}}$

The  $\overline{\text{SD}}$  pin functions as an output pin and is intended for protection-mode signaling to, for example, a controller or other front-end device. The pin is open-drain with an internal pullup resistor to DVDD.

The logic output is, as shown in the following table, a combination of the device state and  $\overline{\text{RESET}}$  input:

$\overline{\text{SD}}$	$\overline{\text{RESET}}$	DESCRIPTION
0	0	Reserved
0	1	Device in protection mode, i.e., UVP and/or OC and/or OT error
1(2)	0	Device set high-impedance (Hi-Z), $\overline{\text{SD}}$ forced high
1	1	Normal operation

(2)  $\overline{\text{SD}}$  is pulled high when  $\overline{\text{RESET}}$  is asserted low independent of chip state (i.e., protection mode). This is desirable to maintain compatibility with some TI PWM front ends.

### Overtemperature Warning Pin: $\overline{\text{OTW}}$

The  $\overline{\text{OTW}}$  pin gives a temperature warning signal when temperature exceeds the set limit. The pin is of the open-drain type with an internal pullup resistor to DVDD.

$\overline{\text{OTW}}$	DESCRIPTION
0	Junction temperature higher than 115°C
1	Junction temperature lower than 115°C

## Overall Reporting

The  $\overline{\text{SD}}$  pin, together with the  $\overline{\text{OTW}}$  pin, gives chip state information as described in Table 1.

**Table 1. Error Signal Decoding**

$\overline{\text{OTW}}$	$\overline{\text{SD}}$	DESCRIPTION
0	0	Overtemperature error (OTE)
0	1	Overtemperature warning (OTW)
1	0	Overcurrent (OC) or undervoltage (UVP) error
1	1	Normal operation, no errors/warnings

## Chip Protection

The TAS5121 protection function is generally implemented in a closed loop control system with, for example, a system controller. The TAS5121 contains three individual systems protecting the device against fault conditions. All of the error events result in the output stage being set in a high-impedance state (Hi-Z) for maximum protection of the device and connected equipment.

The device can be recovered by toggling  $\overline{\text{RESET}}$  low and then high, after all errors are cleared. It is recommended that if the error persists, the device is held in reset until user intervention clears the error.

### Overcurrent (OC) Protection

The device has individual current protection on both high-side and low-side power stage FETs. The OC protection works only with the demodulation filter present at the output. See *Filter Demodulation Design* in the *Application Information* section of the data sheet for design constraints.

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## Overtemperature (OT) Protection

A dual temperature protection system asserts a warning signal when the device junction temperature exceeds 115°C and shuts down the device when the junction temperature exceeds 150°C. The OT protection circuit is shared by both half-bridges.

## Undervoltage Protection (UVP)

Undervoltage lockout occurs when GVDD is insufficient for proper device operation. The UV protection system protects the device under fault power-up and power-down situations by shutting the device down. The UV protection circuits are shared by both half-bridges.

## Reset Function

The reset has two functions:

- Reset is used for re-enabling operation after a latched error event.
- Reset is used for disabling output stage switching, hard mute function. Use modulator control for soft mute.

In protection modes where the reset input functions as the means to re-enable operation after an error event, the error latch is cleared on the falling edge of reset and normal operation is resumed on the rising edge of **RESET**.

## PROTECTION MODE

### Autorecovery (AR) After Errors (PMODE0)

In autorecovery mode (PMODE0) the TAS5121 is self-supported in handling of error situations. All protection systems are active, setting the output stage in the high-impedance state to protect the output stage and connected equipment. However, after a short time the device autorecovers, i.e., operation is automatically resumed provided that the system is fully operational.

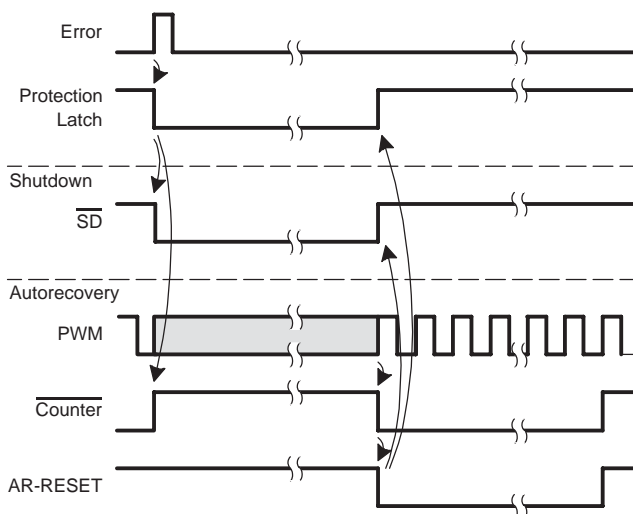
The autorecovery timing is set by counting PWM input cycles, i.e., the timing is relative to the switching frequency.

The AR system is common to both half-bridges.

## Timing and Function

The function of the autorecovery circuit is as follows:

1. An error event occurs and sets the protection latch (output stage goes Hi-Z).
2. The counter is started.
3. After  $n/2$  cycles, the protection latch is cleared but the output stage remains Hi-Z (identical to pulling **RESET** low).
4. After  $n$  cycles, operation is resumed (identical to pulling **RESET** high) ( $n = 512$ ).



**Figure 9. Autorecovery Function**

### Latching Shutdown on All Errors (PMODE1)

In latching shutdown mode, all error situations result in a power down (output stage Hi-Z). Re-enabling can be done by toggling the **RESET** pin.

### All Protection Systems Disabled (PMODE2)

In PMODE2, all protection systems are disabled. This mode is purely intended for testing and characterization purposes and thus not recommended for normal device operation.

### MODE Pins Selection

The protection mode is selected by connecting M1/M2 to DREG or DGND according to Table 2.

**Table 2. Protection Mode Selection**

M1	M2	PROTECTION MODE
0	0	Autorecovery after errors (PMODE 0)
0	1	Latched shutdown on all errors
1	0	Reserved
1	1	Reserved

The output configuration mode is selected by connecting the M3 pin to DREG or DGND according to Table 3.

**Table 3. Output Mode Selection**

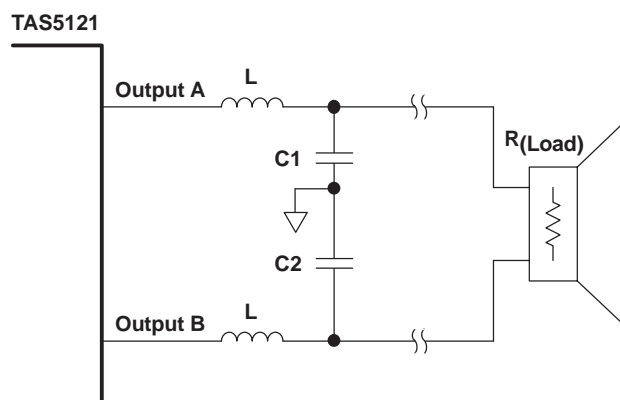
M3	OUTPUT MODE
0	Bridge-tied load output stage (BTL)
1	Reserved

## APPLICATION INFORMATION

### DEMODULATION FILTER DESIGN

The TAS5121 amplifier outputs are driven by high-current DMOS transistors in an H-bridge configuration. These transistors are either off or fully on.

The result is a square-wave output signal with a duty cycle that is proportional to the amplitude of the audio signal. It is recommended that a second-order LC filter be used to recover the audio signal.



**Figure 10. Demodulation Filter**

The main purpose of the demodulation filter is to attenuate the high-frequency components of the output signals that are out of the audio band.

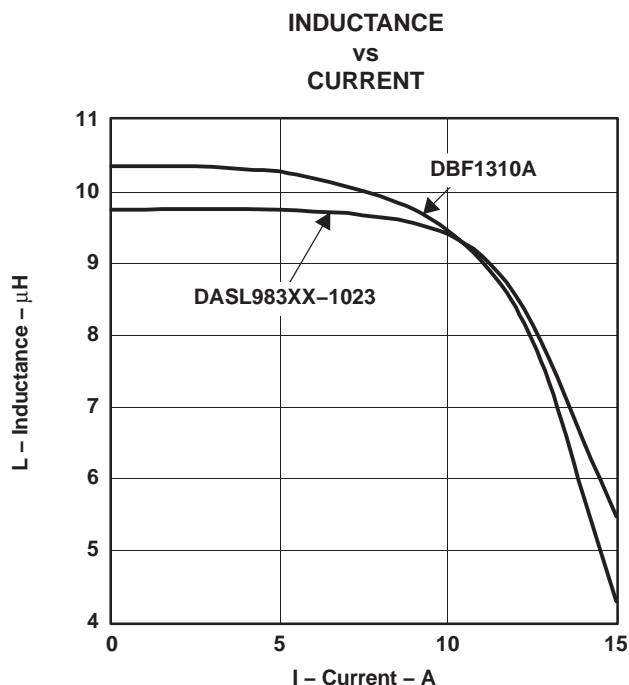
Design of the demodulation filter affects the audio performance of the power amplifier significantly. As a result, to ensure proper operation of the overcurrent (OC) protection circuit and meet the device THD+N specifications, the selection of the inductors used in the output filter must be considered according to the following. The rule is that the inductance should remain stable within the range of peak current seen at maximum output power and deliver approximately 5  $\mu\text{H}$  of inductance at 15 A.

If this rule is observed, the TAS5121 should not have distortion issues due to the output inductors. This prevents device damage due to overcurrent conditions because of inductor saturation in the output filter.

Another parameter to be considered is the idle current loss in the inductor. This can be measured or specified as inductor dissipation (D). The target specification for dissipation is less than 0.05. If this specification is not met, idle current increases.

In general, 10- $\mu\text{H}$  inductors suffice for most applications. The frequency response of the amplifier is slightly altered by the change in output load resistance; however, unless tight control of frequency response is necessary (better than 0.5 dB), it is not necessary to deviate from 10  $\mu\text{H}$ .

The graphs in Figure 11 display the inductance vs current characteristics of two inductors that are suggested for use with the TAS5121.



**Figure 11. Inductance Saturation**

The selection of the capacitors that are placed from the output of each inductor to ground is simple. To complete the output filter, use a 1- $\mu\text{F}$  capacitor with a voltage rating at least twice the voltage applied to the output stage (PVDD\_x).

This capacitor should be a good quality polyester dielectric.

### THERMAL INFORMATION

The following is provided as an example.

The thermally enhanced package provided with the TAS5121 are designed to be interfaced directly to heatsinks using a thermal interface compound (for example, Wakefield Engineering type 126 thermal grease.) The heatsink then absorbs heat from the ICs and transfers it to the ambient air. If the heatsink is carefully designed, this process can reach equilibrium and heat can be continually removed from the ICs without device overtemperature shutdown. Because of the efficiency of the TAS5121, heatsinks are smaller than those required for linear amplifiers of equivalent performance.

## TAS5121

SLES086A – NOVEMBER 2003 – REVISED MARCH 2004

$R_{\theta JA}$  is a system thermal resistance from junction to ambient air. As such, it is a system parameter with roughly the following components:

- $R_{\theta JC}$  (the thermal resistance from junction to case, or in this case the metal pad)
- Heatsink compound thermal resistance
- Heatsink thermal resistance

The thermal grease thermal resistance can be calculated from the exposed pad area and the thermal grease manufacturer's area thermal resistance (expressed in  $^{\circ}\text{C-in}^2/\text{W}$ ). The area thermal resistance of the example thermal grease with a 0.001-inch thick layer is about 0.054  $^{\circ}\text{C-in}^2/\text{W}$ . The approximate exposed pad area is as follows:

36-pin PSOP3      0.116 in<sup>2</sup>

Dividing the example thermal grease area resistance by the area of the pad gives the actual resistance through the thermal grease for the device:

36-pin PSOP3      0.47  $^{\circ}\text{C/W}$

The thermal resistance of thermally conductive pads is generally higher than a thin thermal grease layer. Thermal tape has an even higher thermal resistance and should not be used with this package.

Heatsink thermal resistance is generally predicted by the heatsink vendor, modeled using a continuous flow dynamics (CFD) model, or measured.

Thus, for a single monaural IC, the system  $R_{\theta JA} = R_{\theta JC} + \text{thermal grease resistance} + \text{heatsink resistance}$ .

The following table indicates modeled parameters for one TAS5121 IC on a heatsink. The junction temperature is set at 110 $^{\circ}\text{C}$  while delivering 70 W RMS into 4- $\Omega$  loads with no clipping. It is assumed that the thermal grease is about 0.001 inch thick (this is critical).

**Table 4. Example of Thermal Simulation**

	36-Pin PSOP3
Ambient temperature	25 $^{\circ}\text{C}$
Power to load	70 W
Delta T inside package	5.5 $^{\circ}\text{C}$
Delta T through thermal grease	3.2 $^{\circ}\text{C}$
Required heatsink thermal resistance	11.0 $^{\circ}\text{C/W}$
Junction temperature	110 $^{\circ}\text{C}$
System $R_{\theta JA}$	12.3 $^{\circ}\text{C/W}$
$R_{\theta JA}$ * power dissipation	85 $^{\circ}\text{C}$
$R_{\theta JC}$	0.85 $^{\circ}\text{C/W}$

As an indication of the importance of keeping the thermal grease layer thin, if the thermal grease layer increases to 0.002 inches thick, the required heatsink thermal resistance increases to 5.2 $^{\circ}\text{C/W}$  for the PSOP3 package.

## REFERENCES

1. *Digital Audio Measurements* application report—TI (SLAA114)
2. *PowerPAD™ Thermally Enhanced Package* technical brief—TI (SLMA002)
3. *System Design Considerations for True Digital Audio Power Amplifiers* application report—TI (SLAA117)
4. *Voltage Spike Measurement Technique and Specification* application note—TI (SLEA025)



## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Top-Side Markings (4)	Samples
TAS5026APAGR	NRND	TQFP	PAG	64		TBD	Call TI	Call TI	0 to 70	TAS5026A	

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

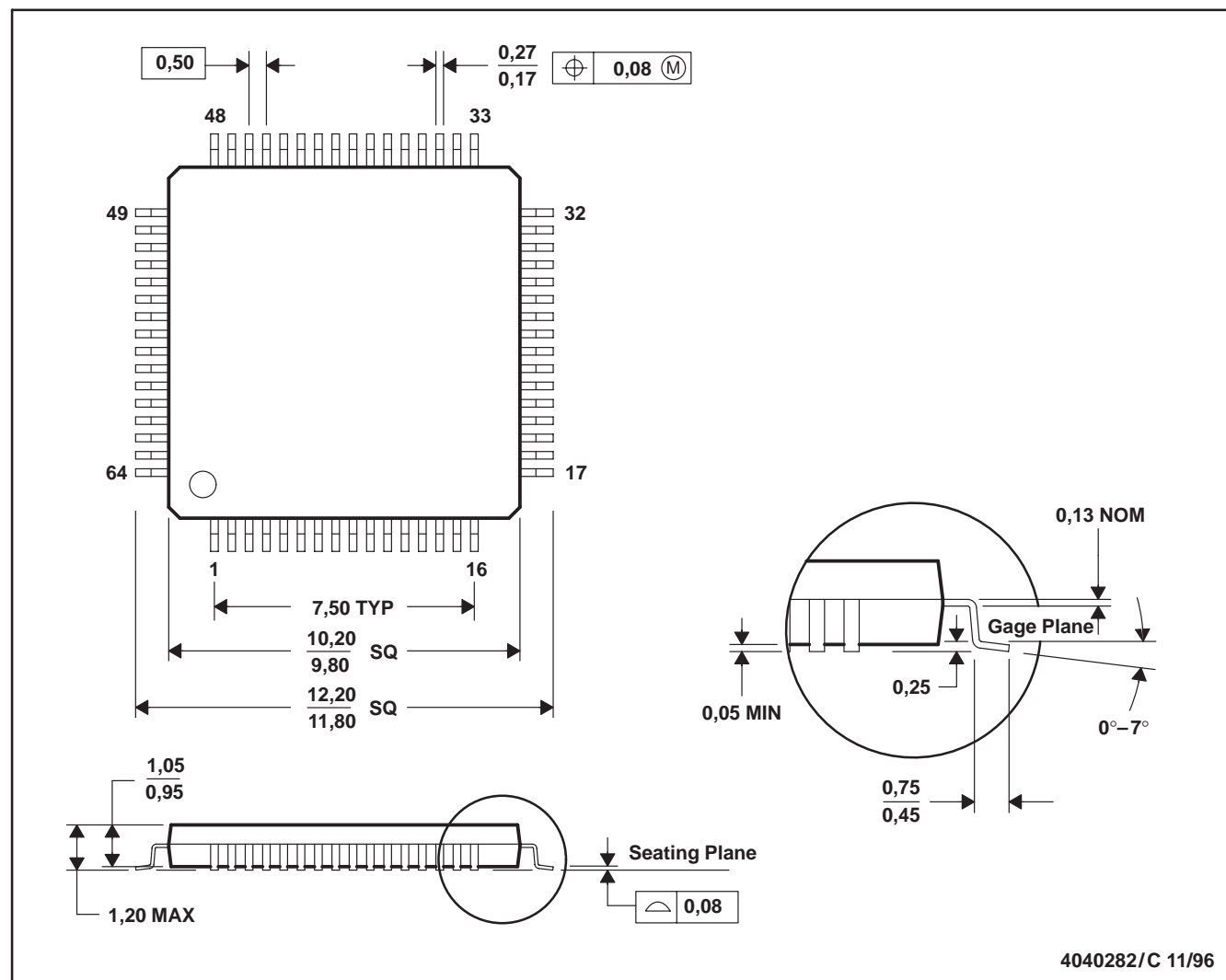
(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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## PAG (S-PQFP-G64)

## PLASTIC QUAD FLATPACK



- NOTES: A. All linear dimensions are in millimeters.  
 B. This drawing is subject to change without notice.  
 C. Falls within JEDEC MS-026



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